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Application/C ntr I No.	Applicant(s)/Patent und r R examination
10/805,809	MADAN ET AL.
Examiner	Art Unit
Son I Mai	2827

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (see search history printouts)	6/11/2006	SM		
Interference Search History Printout	6/11/2006	SM		
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